## Applicant(s)/Patent Under Application/Control No. Reexamination 10/701,462 ONO, YOSHIHARU Notice of References Cited Examiner **Art Unit** Page 1 of 1 1765 Kin-Chan Chen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 06-2001 Harada et al. 438/637 US-6,251,774 Α US-6,800,558 10-2004 Chang et al. 438/700 В 08-2004 438/638 С US-6,774,031 Ali et al. 02-2004 D US-6,692,580 Wu et al. 134/26 03-2000 Lin et al. 430/316 Ε US-6,042,999 Tsai et al. F 12-2001 438/624 US-6,326,296 G US-6,821,896 11-2004 Shih, Tsu 438/692 US-5,705,430 01-1998 Avanzino et al. 438/618 Н 1 US-6,458,707 10-2002 Wada, Takashi 438/694 11-2001 Liu et al. 438/636 J US-6,319,821 07-2002 Chen et al. 438/637 US-6,417,096 Κ 05-2004 Wu et al. 134/26 US-6,733,597 L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν O Р Q R S Т **NON-PATENT DOCUMENTS**

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